


<b>Search Notes</b> 	<b>Application/Control No.</b> 10826509	<b>Applicant(s)/Patent Under Reexamination</b> BAILEY ET AL.
	<b>Examiner</b> Ehichioya, Fred I	<b>Art Unit</b> 2162

SEARCHED			
Class	Subclass	Date	Examiner
707	3, 7, 8, 100, 103Y, 200	9/11/2009	FE
709	213, 217	9/11/2009	FE
711	152, 170, 208, 209	9/11/2009	FE

SEARCH NOTES		
Search Notes	Date	Examiner
East (US-PGPub, USPat, EPO, JPO, Derwent).text saerch only.	7/31/07	FE
East (US-PGPub, USPat, EPO, JPO, Derwent).text saerch updated	1/21/08	FE
ACM Digital Library Search	1/21/08	FE
Google.com	1/21/08	FE
East (US-PGPub, USPat, EPO, JPO, Derwent).text saerch only	9/27/08	FE
Google Patent Search	8/19/08	FE
East (US-PGPub, USPat, EPO, JPO, Derwent).text saerch only	4/27/2009	FE
East (US-PGPub, USPat, EPO, JPO, Derwent).inventor name, class/subclass and text search	9/11/2009	FE
Google Patent Search	9/11/2009	FE
NPL Multi-Search (ACM, IEEE, ProQuest, ... )	9/11/2009	FE

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
707	103Y, 200	9/11/2009	FE

	/FRED I EHICHIOYA/ Primary Examiner.Art Unit 2156
--	--